



High Current Common Mode Choke

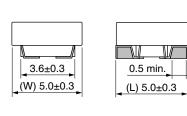
FEATURES

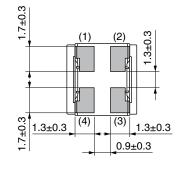
- Surface mountable (multiple case sizes), high current common mode choke for DC power line
- Base terminals are treated, allows for easy mounting on PCB
- Paired wire coil for high stability
- Optimized for transmission of high quality signals
- Operating temperature: -40 °C to +125 °C
- Rated Current: Based on temp. rise; ∆T: 40 °C, typical
- Material categorization: For definitions of compliance please see

APPLICATIONS

- LAN's, telephones, personal computers
- CD-ROM drives, electronic games
- Other electronic devices

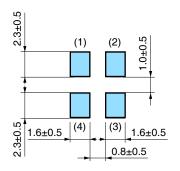
STANDARD ELECTRICAL SPECIFICATIONS					
PART NUMBER	COMMON MODE IMPEDANCE AT 100 MHz (Ω)	RATED VOLTAGE MAX. (V _{DC})	RATED CURRENT MAX. (mA)	DC RESISTANCE MAX. (Ω)	INSULATION RESISTANCE MIN. (MΩ)
CMF2G101WIT	100±25%	50	6000	0.009	10
CMF2G251WIT	250±25%	50	5000	0.014	10
CMF2G501WIT	500±25%	50	4000	0.019	10
CMF2G102WIT	1000±25%	50	2000	0.024	10
CMF2G152WIT	1500±25%	50	1500	0.040	10



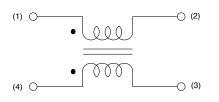


(T) 2.4±0.15

0.45 min.



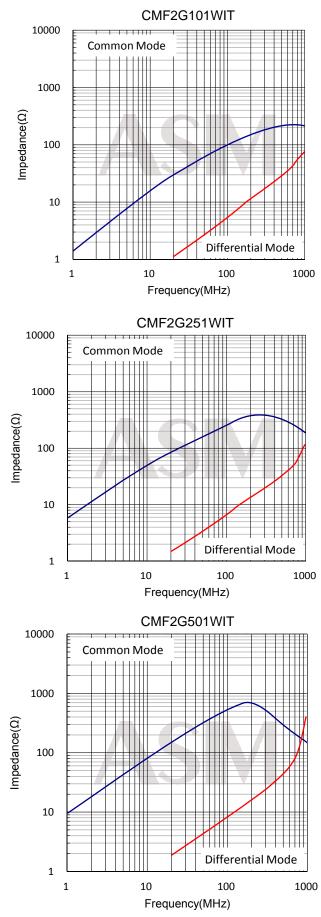
Unit :mm





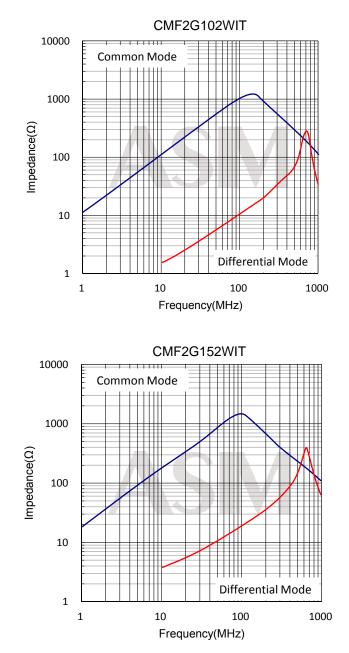


PERFORMANCE GRAPHS: INDUCTANCE AND Q VS. FREQUENCY



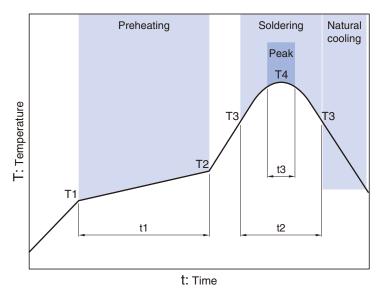


PERFORMANCE GRAPHS: INDUCTANCE AND Q VS. FREQUENCY





RECOMMENDED REFLOW PROFILE



Preheating Soldering Peak Temp. Time Temp. Time Temp. Time T2 T1 t1 Т3 t2 **T**4 t3 150°C 180°C 60 to 120s 230°C 25 to 35s 250°C 5s

RELIABLITY TEST METHOD

• ELECTRIC

NO.	Test items	Standard	Experiment Method
1	Temperature characteristics	ΔL/L 20°C ≤ ±10%	The test should be done after the sample has stabilized in the ring The temperature of the product is -40 to +125 °C, and the L (Δ L) value of the product is the same as the original L value. Suitable for normal temperature and humidity should be Δ L / L 20 ° C ≤ ± 10 %.
2	Load test	The product must not have any damage, such as smoke or sparks	1.2 times the rated current, the time is 5 minutes



6.2 ENVIRONMENTAL CHARACTERISTICS

NO.	Test items	Standard	Experiment Method	
1	Reflow soldering	Do not have any damage or problems	Reflow of temperature distribution Before the heat: 150-180 °C, Times 60 to 120sec Peak temperature: 250 ± 5 °C, Times 5 sec Hold temperature: 230 ± 5 °C, Times 30 ± 5 sec $\frac{250\pm5^{\circ}C}{150^{\circ}C} \xrightarrow{55}{120^{\circ}} \xrightarrow{120^{\circ}} 120^{$	
2	Solderability		The solder surface is immersed in flux and then immersed in a furnace at 235 \pm 5 °C for 5 seconds	
3	Low temperature storage	there should be no	The sample should be left for 96 \pm 4 hours at a temperature of -40 \pm 3 °C and returned to the normal temperature range of 1 hour after completion of the test.) 90-95%.	
4	High temperature storage	there should be no	ere should be no 125 ± 3 °C. The test should be carried out after returning to norm	
5	Constant hot and humid	$\Delta L / L0 \le \pm 10\%$, there should be no to 90% humidity (RH). The test is resumed after 1 hour in normal temperature range.		
6	Temperature cycle	1, no visible mechanical damage. 2, the value of change is less than 10%. 3, the resistance value of less than 5%	In the -25 °C to +85 °C between the respective keep 15min, transit time ≤1min, the number of cycles 5 times, recovery time: 24h test finished (recovery time at least 4h)	
7	vibration	There should be no mechanical damage	The sample should be soldered to the printed circuit board When the vibration has an amplitude and 1.5 mm Frequency from 10-55Hz / 1 minute, repeated should be applied to three directions (X, Y, Z) for 2 hours, a total of 6 hours	
8	Impact resistance (MIL-STD-202G Method 213B)	DC resistance change: ± 10% within the appearance of no obvious	The test sample shall be soldered to the test substrate by reflow soldering. Then, follow the following test conditions. Pulse Half sine shock Acceleration 980 m/s ² (100g) Nominal pulse duration 6 ms Speed change 3.75 m/s Recovery: 2 hours of recovery in standard condition and subsequent testing within 48 hours.	



		Change in inductance: within ±	The test sample shall be soldered to the test substrate by reflow soldering. Test sample according to the specified time Are placed at a specific temperature, as shown in the table below,
9	Thermal shock (MIL-STD-202G Method 107G)	10% DC resistance change: ± 10% within the appearance of no obvious abnormalities, should not have mechanical damage.	$\begin{array}{c ccccc} 1 & -55 \pm 3 & 30 \pm 3 \\ \hline 2 & \text{Room temperature} & 3 \text{ or less} \\ \hline 3 & -125 \pm 3 & 30 \pm 3 \end{array}$
10	Wet heat resistance (MIL-STD-202G Method 106G)	Change in inductance: within ± 10% DC resistance change: ± 10% within the appearance of no obvious abnormalities, should not have mechanical damage.	Time 500±24 hours
11	Low temperature life (IEC68-2-1Ad)	Change in inductance: within ± 10% DC resistance change: ± 10% within the appearance of no obvious abnormalities, should not have mechanical damage.	The test sample shall be soldered to the test substrate by reflow soldering. The test sample should then be placed in the test conditions as shown in the table below. Temperature -40±3°C Time 500±24 hours Recovery: 2 hours of recovery in standard condition and subsequent testing within 48 hours.
12	Low temperature load life (IEC68-2-1Ad)	Change in inductance: within ± 10% DC resistance change: ± 10% within the appearance of no obvious abnormalities, should not have mechanical damage.	100 ± 24 nours
13	Damp heat load (MIL-STD-202G Method 108A)	Change in inductance: within ± 10% DC resistance change: ± 10% within the appearance of no obvious abnormalities, should not have mechanical damage.	Temperature 60±2°C Humidity 90~95%RH Time 500±24 hours



14	High temperature life test (IEC68-2-2Ba)	DC resistance change: ± 10% within the appearance of no obvious	The test sample shall be soldered to the test substrate by reflow soldering. The test sample shall be placed in a constant temperature and humidity tank and the current shall not be supplied at the temperature specified in the table. Temperature 125±3°C Time 500±24 hours Recovery: 2 hours of recovery in standard condition and subsequent testing within 48 hours.
15	High temperature load life test (MIL-STD-202G Method 108A)	10% DC resistance change: ± 10% within the appearance of no obvious	The test sample shall be soldered to the test substrate by reflow soldering. The Temperature 85±2°C Plus load current Rated current Time 2000±24 hours Hourly power time 3/4 power 1/4 power off Recovery: 2 hours of recovery in standard condition and subsequent testing within 48 hours.